

IR MOSFET™

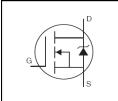
Features

- Advanced Process Technology
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- · Ease of Paralleling
- Simple Drive Requirements
- Lead-Free

Description

IR MOSFET™ technology from Infineon utilizes advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and rugged device design that IR MOSFET™ devices are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-247 package is preferred for commercialindustrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole.



V _{(BR)DSS}	200V
R _{DS(on)} max.	0.04Ω
I _D	50A



G	D	S
Gate	Drain	Source

Base part number	Packago Typo	Standard Pack Form Quantity		Orderable Part Number
Dase part number	Package Type			Orderable Fait Number
IRFP260MPbF	TO-247AD	Tube	25	IRFP260MPbF

Absolute Maximum Ratings

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	50	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	35	Α
I _{DM}	Pulsed Drain Current ①⑤	200	
P _D @T _C = 25°C	Maximum Power Dissipation	300	W
	Linear Derating Factor	2.0	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy ②⑤	560	mJ
I _{AR}	Avalanche Current ①⑤	50	Α
E _{AR}	Repetitive Avalanche Energy ①	30	mJ
dv/dt	Peak Diode Recovery dv/dt③⑤	10	V/ns
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range	-55 10 + 175	°C
_	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case		0.50	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.24		°C/W
Reja	Junction-to-Ambient		40	

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Electrical characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	200			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.26		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.04	Ω	V _{GS} = 10V, I _D = 28A ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	27			S	$V_{DS} = 50V, I_{D} = 28A$
1	Drain-to-Source Leakage Current			25	111/	$V_{DS} = 200V, V_{GS} = 0V$
IDSS	Diam-to-Source Leakage Current			250	μ	$V_{DS} = 160V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
	Gate-to-Source Forward Leakage			100	nΛ	V _{GS} = 20V
IGSS	Gate-to-Source Reverse Leakage			-100	nA	$V_{GS} = -20V$

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Q_g	Total Gate Charge	 	234		I _D = 28A
Q_{gs}	Gate-to-Source Charge	 	38	nC	V _{DS} = 160V
Q_{gd}	Gate-to-Drain Charge	 	110		V _{GS} = 10V, See Fig.6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	 17			$V_{DD} = 100V$
t _r	Rise Time	 60		no	$I_D = 28A$
$t_{d(off)}$	Turn-Off Delay Time	 55		ns	R_G = 1.8 Ω
t _f	Fall Time	 48			V _{GS} = 10V, See Fig.10④
L_D	Internal Drain Inductance	 5.0			Between lead, 6mm (0.25in.)
Ls	Internal Source Inductance	 13		11171	from package and center of die contact
C _{iss}	Input Capacitance	 4057			$V_{GS} = 0V$
C_{oss}	Output Capacitance	 603		pF	$V_{DS} = 25V$
C_{rss}	Reverse Transfer Capacitance	 161			f = 1.0MHz, See Fig.5

Diode Characteristics

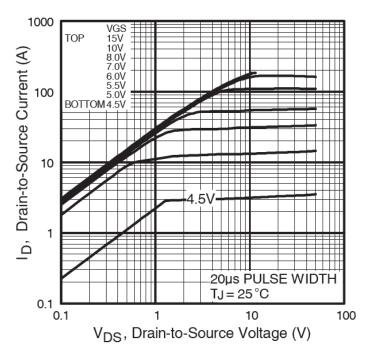
1		1		I	I	
	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			50		MOSFET symbol showing the
I _{SM}	Pulsed Source Current			200		integral reverse
· · · ·	(Body Diode) ①					p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 28A, V_{GS} = 0V $ ④
t _{rr}	Reverse Recovery Time		268	402	ns	$T_J = 25^{\circ}C$, $I_F = 28A$
Q_{rr}	Reverse Recovery Charge		1.9	2.8	μC	di/dt = 100A/μs ④

Notes

- $\, \mathbb{O} \,$ Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Starting T_J = 25°C, L = 1.5mH, R_G = 25 Ω , I_{AS} = 28A.(See fig. 12).
- $\label{eq:local_local_local} \text{\Im} \quad I_{SD} \leq 28 \text{A, di/dt} \leq 486 \text{A/} \mu \text{s, } V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ} C.$
- 4 Pulse width $\leq 400 \mu s$; duty cycle $\leq 2\%$.

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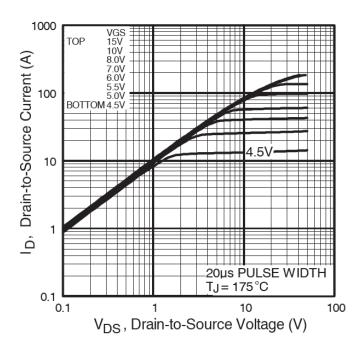
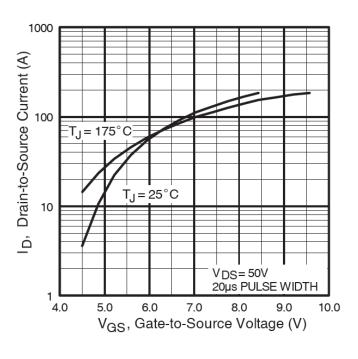


Fig. 1 Typical Output Characteristics

Fig. 2 Typical Output Characteristics



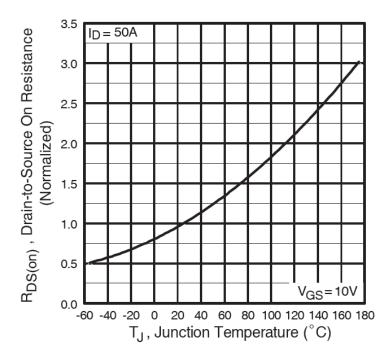
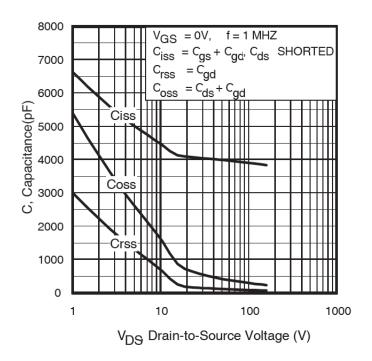


Fig. 3 Typical Transfer Characteristics

Fig. 4 Normalized On-Resistance vs. Temperature





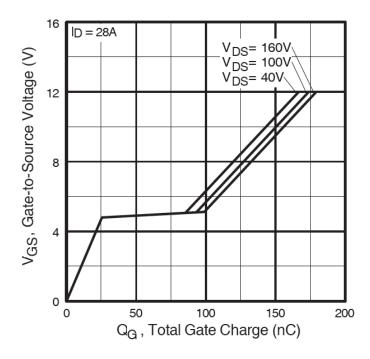
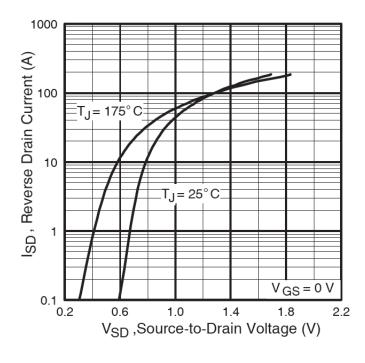


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage







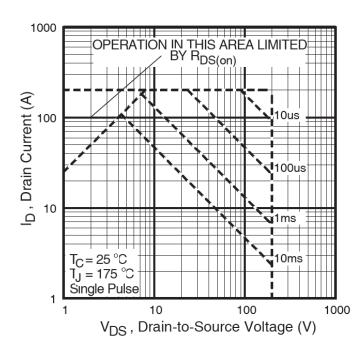


Fig 8. Maximum Safe Operating Area

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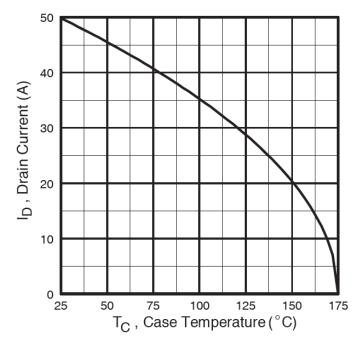


Fig 9. Maximum Drain Current vs. Case Temperature

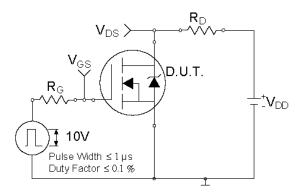


Fig 10a. Switching Time Test Circuit

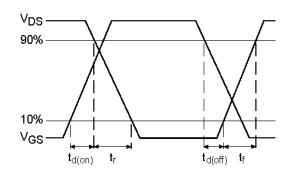


Fig 10a. Switching Time Waveforms

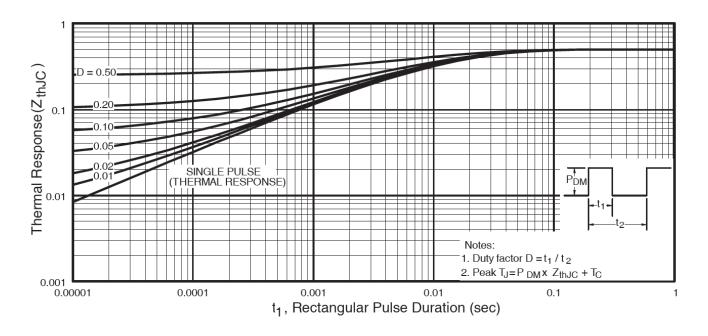


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



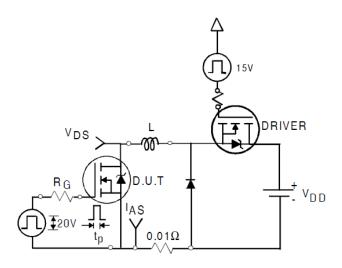


Fig. 12a. Unclamped Inductive Test Circuit

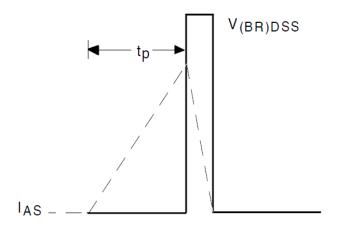


Fig. 12b. Unclamped Inductive Waveforms

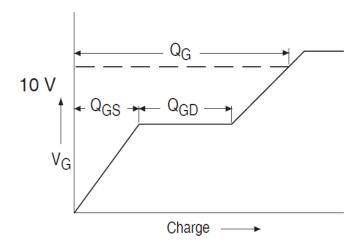


Fig 13a. Basic Gate Charge Waveform

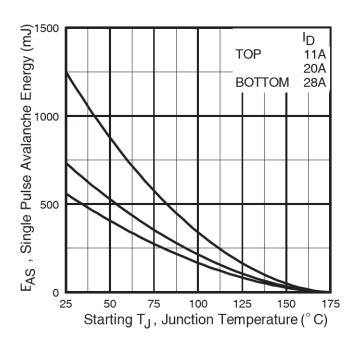


Fig 12c. Maximum Avalanche Energy vs. Drain Current

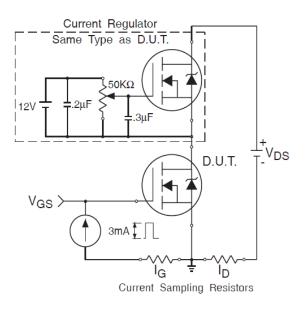
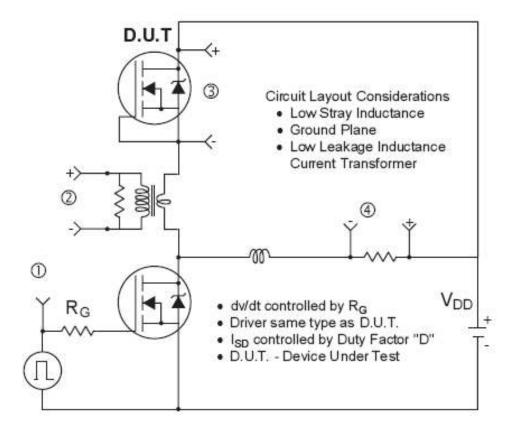


Fig 13b. Gate Charge Test Circuit





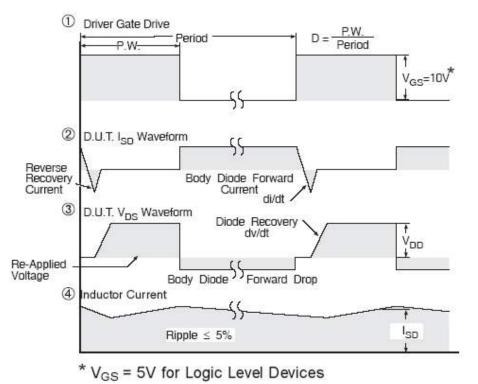
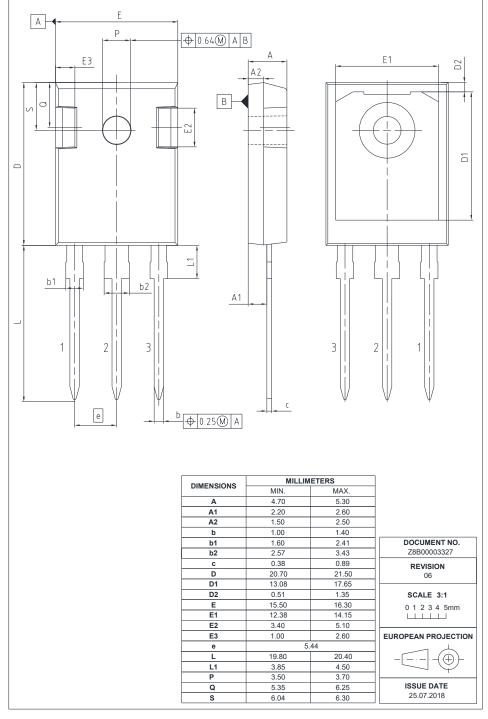


Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel IR MOSFET™



TO-247AD Package Outline (Dimensions are shown in millimeters (inches))

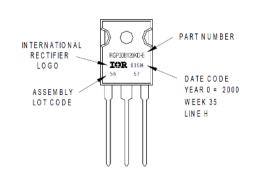


TO-247AD Part Marking Information

EXAMPLE: THIS IS AN IRGP30B120KD-E WITH ASSEMBLY

LOT CODE 5657 ASSEMBLED ON WW 35, 2000 IN THE ASSEMBLY LINE "H"

Note: "P" in assembly line position indicates "Lead-Free"





Revision History

Date	Comments			
	Updated datasheet with corporate template			
05/29/2020	Updated Package picture-page1			
03/26/2020	05/28/2020 • Corrected from "Hexfet power MOSFET" to "IR MOSFET™" -page1 &7			
	Corrected part marking from TO-247AC to TO-247AD on page 8.			

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